





EH29 00 ET T TS -4.9152M

Frequency Tolerance/Stability ±100ppm Maximum

Operating Temperature Range – -40°C to +85°C Nominal Frequency 4.9152MHz

Tri-State (High Impedance)

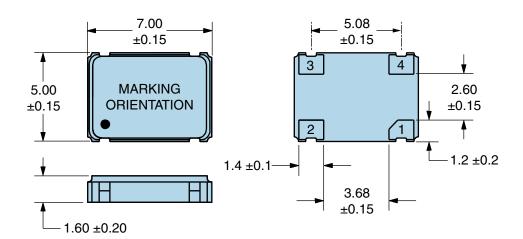
- Duty Cycle 50 ±5(%)

Frequency Tolerance/Stability ±100 Oper. 260°C 45pp Operating Temperature Range -40°C Supply Voltage 1.8VC Output Voltage Logic High (Voh) Output Voltage Logic Low (Vol) 10%	152MHz Doppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the erating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°,
Operation at 25°C ±5pp Operating Temperature Range -40°C Supply Voltage 1.8Vc Output Voltage Logic High (Voh) 90% Output Voltage Logic Low (Vol) 10%	
Operating Temperature Range -40°C Supply Voltage 1.8Vc nput Current 3.5m. Output Voltage Logic High (Voh) 90% Output Voltage Logic Low (Vol) 10%	oraling Temperature Narige, Supply Voltage Sharige, Supply Load Sharige, This Tear Aging at 25 , 19°C Reflow, Shock, and Vibration)
Supply Voltage 1.8Vo nput Current 3.5m. Output Voltage Logic High (Voh) 90% Output Voltage Logic Low (Vol) 10%	ppm/Year Maximum
nput Current 3.5m. Output Voltage Logic High (Voh) 90% Output Voltage Logic Low (Vol) 10%	°C to +85°C
Output Voltage Logic High (Voh) 90% Output Voltage Logic Low (Vol) 10%	Vdc ±5%
Output Voltage Logic Low (Vol) 10%	mA Maximum (No Load)
	% of Vdd Minimum (IOH = -8mA)
	% of Vdd Maximum (IOL = +8mA)
Rise/Fall Time 6nSe	Sec Maximum (Measured at 20% to 80% of waveform)
Outy Cycle 50 ±5	±5(%) (Measured at 50% of waveform)
oad Drive Capability 15pF	of Maximum
Output Logic Type CMO	OS
Pin 1 Connection Tri-St	State (High Impedance)
,	% of Vdd Minimum or No Connect to Enable Output, 10% of Vdd Maximum to Disable Output (High pedance)
Standby Current 10µA	JA Maximum (Pin 1 = Ground)
Absolute Clock Jitter ±100	00pSec Maximum
Start Up Time 10mS	nSec Maximum
Storage Temperature Range -55°C	

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS		
ESD Susceptibility	MIL-STD-883, Method 3015, Class 1, HBM: 1500V	
Fine Leak Test	MIL-STD-883, Method 1014, Condition A	
Flammability	UL94-V0	
Gross Leak Test	MIL-STD-883, Method 1014, Condition C	
Mechanical Shock	MIL-STD-883, Method 2002, Condition B	
Moisture Resistance	MIL-STD-883, Method 1004	
Moisture Sensitivity	J-STD-020, MSL 1	
Resistance to Soldering Heat	MIL-STD-202, Method 210, Condition K	
Resistance to Solvents	MIL-STD-202, Method 215	
Solderability	MIL-STD-883, Method 2003	
Temperature Cycling	MIL-STD-883, Method 1010, Condition B	
Vibration	MIL-STD-883, Method 2007, Condition A	



MECHANICAL DIMENSIONS (all dimensions in millimeters)



PIN	CONNECTION
1	Tri-State
2	Case Ground
3	Output
4	Supply Voltage

LINE	MARKING
1	ECLIPTEK
2	4.9152M
3	XXXXXX XXXXXX=Ecliptek Manufacturing Identifier

Suggested Solder Pad Layout

All Dimensions in Millimeters



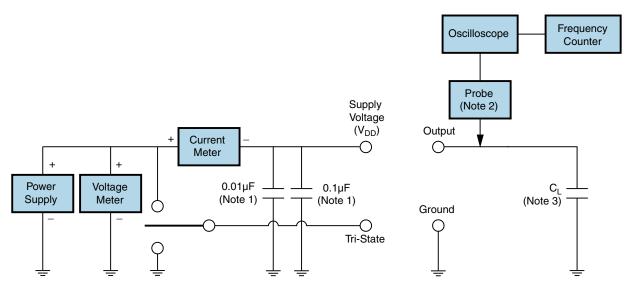
All Tolerances are ±0.1



OUTPUT WAVEFORM & TIMING DIAGRAM



Test Circuit for CMOS Output

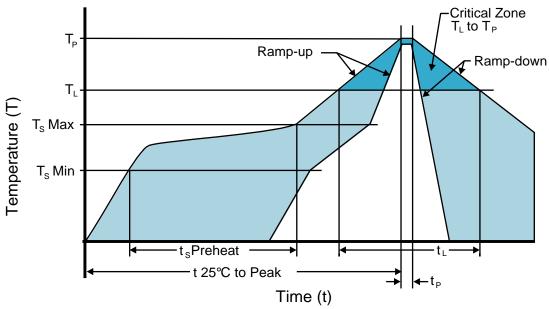


- Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close (less than 2mm) to the package ground and supply voltage pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

 Note 3: Capacitance value C_L includes sum of all probe and fixture capacitance.



Recommended Solder Reflow Methods

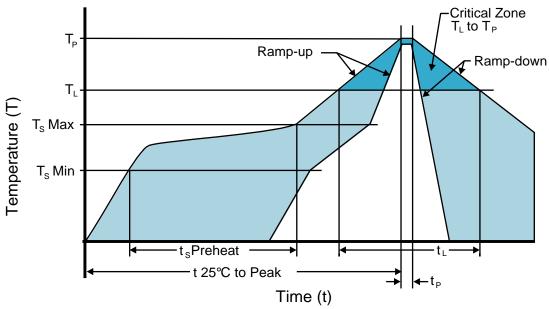


High Temperature Infrared/Convection

<u> </u>	
T _s MAX to T _∟ (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (T _S MIN)	150°C
- Temperature Typical (T _s TYP)	175°C
- Temperature Maximum (T _s MAX)	200°C
- Time (t _s MIN)	60 - 180 Seconds
Ramp-up Rate (T _L to T _P)	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T _P)	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T _P Target)	250°C +0/-5°C
Time within 5°C of actual peak (tp)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.



Recommended Solder Reflow Methods



Low Temperature Infrared/Convection 240°C

T _s MAX to T _L (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	N/A
- Temperature Typical (T _s TYP)	150°C
- Temperature Maximum (T _s MAX)	N/A
- Time (t _s MIN)	60 - 120 Seconds
Ramp-up Rate (T _L to T _P)	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T _P)	240°C Maximum
Target Peak Temperature (T _P Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times
Time within 5°C of actual peak (tp)	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)